

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10571866	VEELAERT ET AL.
	Examiner	Art Unit
	YUN QIAN	4162

SEARCHED

Class	Subclass	Date	Examiner
	EAST search in PG-pub, PAT, Dewent, EPO and JPO; 536/128 text and 127/65, 67, 71 text.	7/7/2008	yq
	Consult with Curtis Mayes	7/8/2008	yq

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner